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- EPIC<sup>™</sup> (Enhanced-Performance Implanted **CMOS) Process**
- Typical V<sub>OLP</sub> (Output Ground Bounce) < 0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> =  $25^{\circ}$ C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot) > 2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> =  $25^{\circ}$ C
- Latch-Up Performance Exceeds 250 mA Per **JESD 17**
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- **Package Options Include Plastic** Small-Outline (D, NS), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), and Thin Shrink Small-Outline (PW) Packages, Ceramic Flat (W) Packages, Chip Carriers (FK), and DIPs (J)

### description

The 'LV86A devices are quadruple 2-input exclusive-OR gates designed for 2-V to 5.5-V V<sub>CC</sub> operation.

These devices contain four independent 2-input exclusive-OR gates. They perform the Boolean function  $Y = A \oplus B$  or  $Y = \overline{AB} + A\overline{B}$  in positive logic.

A common application is as a true/complement element. If one of the inputs is low, the other input is reproduced in true form at the output. If one of the inputs is high, the signal on the other input is reproduced inverted at the output.

The SN54LV86A is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74LV86A is characterized for operation from -40°C to 85°C.

FUNCTION TABLE (each gate)										
INP	UTS	OUTPUT								
Α	В	Y								
L	L	L								
L	Н	Н								
н	L	Н								
Н	Н	L								



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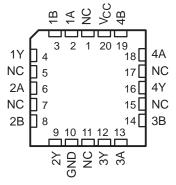
UNLESS OTHERWISE NOTED this document contains PRODUCTION DATA information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters



SN54	LV86A J OR W PACKAGE
SN74LV86A.	D, DB, DGV, NS, OR PW PACKAGE
	(TOP VIEW)

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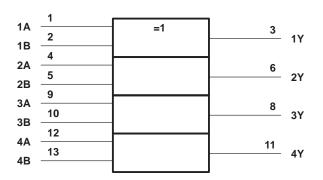
SN54LV86A ... FK PACKAGE (TOP VIEW)



NC - No internal connection

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### logic symbol<sup>†</sup>

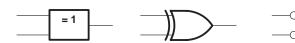


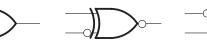
<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, DGV, J, NS, PW, and W packages.

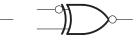
### exclusive-OR logic

An exclusive-OR gate has many applications, some of which can be represented better by alternative logic symbols.

**Exclusive OR** 



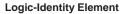


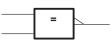


These are five equivalent exclusive-OR symbols valid for an 'LV86A gate in positive logic; negation can be shown at any two ports.

**Even-Parity Element** 

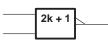
2k





The output is active (low) if all inputs stand at the same logic level (i.e., A = B).

The output is active (low) if an even number of inputs (i.e., 0 or 2) are active. **Odd-Parity Element** 



The output is active (high) if an odd number of inputs (i.e., only 1 of the 2) are active.



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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, $V_{CC}$ Input voltage range, $V_I$ (see Note 1) Output voltage range, $V_O$ (see Notes 1 and 2)		-0.5  V to 7 V
Input clamp current, $I_{IK}$ (V <sub>I</sub> < 0)		
Output clamp current, $I_{OK}$ (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>C</sub>		
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$		±25 mA
Continuous current through V <sub>CC</sub> or GND		±50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3)		
-	DB package	158°C/W
	DGV package	182°C/W
	NS package	127°C/W
	PW package	
Storage temperature range, T <sub>stg</sub>		

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

- 2. This value is limited to 7 V maximum.
- 3. The package thermal impedance is calculated in accordance with JESD 51.

### recommended operating conditions (see Note 4)

			SN54	SN54LV86A		LV86A	UNIT	
			MIN	MAX		MAX	UNIT	
VCC	Supply voltage		2	5.5	2	5.5	V	
		$V_{CC} = 2 V$	1.5		1.5			
Viiii	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	$V_{CC} \times 0.1$	7	$V_{CC} \times 0.7$	7	V	
VIH		$V_{CC} = 3 V \text{ to } 3.6 V$	$V_{CC} \times 0.7$	7	$V_{CC} \times 0.7$	7	v	
		$V_{CC}$ = 4.5 V to 5.5 V	$V_{CC} \times 0.7$	7	$V_{CC} \times 0.7$	7		
		$V_{CC} = 2 V$		0.5		0.5		
VIL	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	,	$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	V	
	Low-level input voltage	$V_{CC} = 3 V \text{ to } 3.6 V$	,	VCC × 0.3		$V_{CC} \times 0.3$	v	
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	,	VCC × 0.3		$V_{CC} \times 0.3$	1	
VI	Input voltage		0	5.5	0	5.5	V	
VO	Output voltage		0	<pre>◇ V<sub>CC</sub></pre>	0	VCC	V	
		$V_{CC} = 2 V$	<i>V</i> o	-50		-50	μA	
lau	I Pak Incol and a superior	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	20	-2		-2		
ЮН	High-level output current	$V_{CC} = 3 V \text{ to } 3.6 V$	54	-6		-6	mA	
		2   Notage   VCC = 2 V   VCC = 2 V   VCC = 3 V to 3.6 V   VCC × 0.7   VCC = 4.5 V to 5.5 V VCC × 0.7   VCC = 4.5 V to 5.5 V VCC × 0.7   VCC = 2 V VCC = 2 V   VCC = 3 V to 3.6 V VCC   VCC = 3 V to 3.6 V VCC   VCC = 3 V to 3.6 V VCC   VCC = 4.5 V to 5.5 V VCC   0 V   V   VCC = 2 V   VCC = 2 V V   VCC = 3 V to 3.6 V V   VCC = 3 V to 3.6 V V   VCC = 2 V V   VCC = 3 V to 3.6 V V   VCC = 3 V to 3.6 V V   VCC = 3 V to 3.6 V 0   VCC = 3 V to 3.6 V 0   VCC = 4.5 V to 5.5 V 0	-12		-12			
		$V_{CC} = 2 V$		50		50	μA	
la:	Low-level output current	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		2		2		
IOL	Low-level output current	$V_{CC} = 3 V \text{ to } 3.6 V$		6		6	mA	
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		12		12		
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	0	200	0	200		
$\Delta t / \Delta v$	Input transition rise or fall rate	V <sub>CC</sub> = 3 V to 3.6 V	0	100	0	100	ns/V	
		V <sub>CC</sub> = 4.5 V to 5.5 V	0	20	0	20		
Тд	Operating free-air temperature		-55	125	-40	85	°C	

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54LV86A	SN74LV86A	UNIT
PARAMETER	TEST CONDITIONS	VCC	MIN TYP MAX	MIN TYP MAX	UNIT
	I <sub>OH</sub> = -50 μA	2 V to 5.5 V	V <sub>CC</sub> -0.1	V <sub>CC</sub> -0.1	
Mari	$I_{OH} = -2 \text{ mA}$	2.3 V	2	2	V
VOH	$I_{OH} = -6 \text{ mA}$	3 V	2.48	2.48	v
	$I_{OH} = -12 \text{ mA}$	4.5 V	3.8	3.8	
	I <sub>OL</sub> = 50 μA	2 V to 5.5 V	0.1	0.1	
Ve	$I_{OL} = 2 \text{ mA}$	2.3 V	0.4	0.4	V
VOL	I <sub>OL</sub> = 6 mA	3 V	0.44	0.44	v
	I <sub>OL</sub> = 12 mA	4.5 V	0.55	0.55	
lj	$V_{I} = V_{CC}$ or GND	5.5 V	2 ±1	±1	μΑ
Icc	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V	20	20	μA
loff	$V_{I} \text{ or } V_{O} = 0 \text{ to } 5.5 \text{ V}$	0 V	5	5	μA
Ci	$V_{I} = V_{CC}$ or GND	3.3 V	1.4	1.4	pF

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 2.5 V $\pm$ 0.2 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	Тį	λ = 25°C	;	SN54LV86A	SN74L	V86A	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN MAX	MIN	MAX	UNIT
<sup>t</sup> pd*	A or B	Y	CL = 15 pF		7.9	17.6	0 21	1	21	ns
<sup>t</sup> pd	A or B	Y	C <sub>L</sub> = 50 pF		10.5	22.6	26.5	1	26.5	ns

\* On products compliant to MIL-PRF-38535, this parameter is not production tested.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T,	<b>₄ = 25°C</b>	;	SN54LV86A	SN74L	V86A	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MIN	MAX	UNIT
<sup>t</sup> pd*	A or B	Y	CL = 15 pF		5.5	11	CI 13	1	13	ns
<sup>t</sup> pd	A or B	Y	C <sub>L</sub> = 50 pF		7.4	14.5	1 16.5	1	16.5	ns

\* On products compliant to MIL-PRF-38535, this parameter is not production tested.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

	PARAMETER	FROM	то	LOAD	T,	ן = 25°C	;	SN54LV86	iΑ	SN74L	V86A	UNIT
	FARAIVIETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	АΧ	MIN	MAX	UNIT
	<sup>t</sup> pd <sup>*</sup>	A or B	Y	C <sub>L</sub> = 15 pF		3.7	6.8		8	1	8	ns
	<sup>t</sup> pd	A or B	Y	C <sub>L</sub> = 50 pF		5.3	8.8	P of	10	1	10	ns

\* On products compliant to MIL-PRF-38535, this parameter is not production tested.



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# noise characteristics, V\_{CC} = 3.3 V, C<sub>L</sub> = 50 pF, T<sub>A</sub> = 25°C (see Note 5)

	PARAMETER	SN74LV86A     MIN   TYP   MAX     0.2   0.8     -0.1   -0.8	UNIT		
	PARAMETER	MIN	TYP	<b>MAX</b> 0.8	UNIT
V <sub>OL(P)</sub>	Quiet output, maximum dynamic V <sub>OL</sub>		0.2	0.8	V
VOL(V)	Quiet output, minimum dynamic V <sub>OL</sub>		-0.1	-0.8	V
VOH(V)	Quiet output, minimum dynamic V <sub>OH</sub>		3.1		V
VIH(D)	High-level dynamic input voltage	2.31			V
V <sub>IL(D)</sub>	Low-level dynamic input voltage			0.99	V

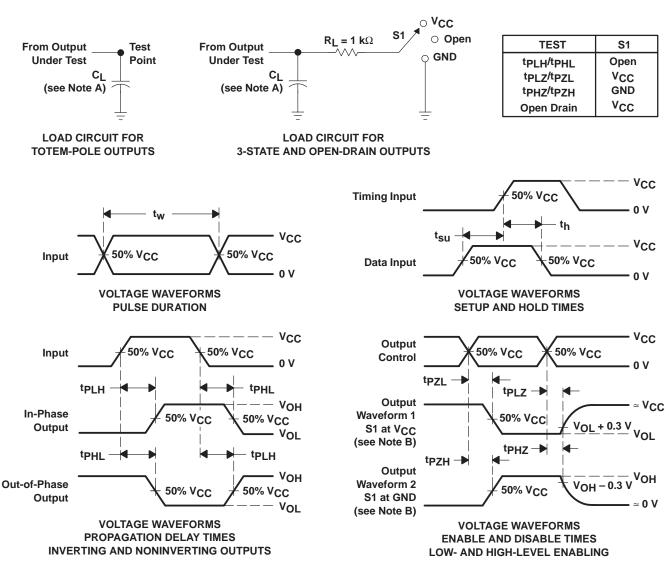
NOTE 5: Characteristics are for surface-mount packages only.

### operating characteristics, $T_A = 25^{\circ}C$

	PARAMETER		TEST CONDITIONS			UNIT
Card	Power discipation canacitance	$C_{1} = 50  \text{pF},$	f = 10 MHz	3.3 V	8.4	ъĒ
Cpd	Power dissipation capacitance	$C_{L} = 50 \text{ pF},$	1 - 10 10112	5 V	8.8	рF



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PARAMETER MEASUREMENT INFORMATION

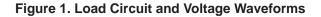
#### NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.

F. tpzL and tpzH are the same as ten.

G. tPHL and tPLH are the same as tpd.





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